

**LIST OF PRIOR ART CITED BY
APPLICANT**
(PTO-1449)

ATTY. DOCKET NO.
LGS/S-0030A

APPLN. SERIAL NO.
Divisional of
09/290,891

APPLICANT(S)
Joo-Hyong LEE

FILING DATE
September 19, 2001

GROUP
Art Unit

PRO
US 55288
09/19/01

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
	5,677,209	10/1997	SHON et al.	148	DIG. 10	
	5,966,599	10/1999	WALKER et al.	438	228	
	5,963,798	10/1999	KIM et al.	438	199	
	5,010,034	04/1991	MANOLIU	438	207	
	5,013,671	05/1991	HAVEMANN	148	DIG. 10	
	5,047,357	09/1991	EKLUND	438	207	
	5,342,794	08/1994	WEI	438	374	
	5,407,840	04/1995	MANOLIU et al.	438	202	
	5,436,176	07/1995	SHIMIZU et al.	438	526	
	6,069,048	05/2000	DANIEL	438	370	
	5,877,049	03/1999	LIU et al.	438	224	

U.S. PATENT APPLICATION PUBLICATIONS

*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS

U.S. PATENT APPLICATIONS

*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

	Ajith Amerasekera et al., "Designing Latchup Robustness in a 0.35 μm Technology", IEEE/IRPS 1994, pp. 280-283.				

EXAMINER

DATE CONSIDERED

6/17/02

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
	5,899,714	05/1999	FARRENKOPF et al.	438	202	
	5,840,603	11/1998	SAKAMOTO	438	202	
	5,622,885	04/1997	MERRILL et al.	438	220	
	4,839,630	08/1989	JOSQUIN	438	234	
	5,338,986	08/1994	KURIMOTO	327	566	
	5,831,313	11/1998	HAN et al.	257	371	
	5,960,277	09/1999	BLANCHARD	438	234	
	4,877,748	10/1989	HAVEMANN	438	371	
	4,408,387	10/1983	KIRISEKO	438	372	
	5,441,900	08/1995	BULUCEA et al.	438	199	

U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS

U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS

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